

Notice of References Cited	Application/Control No. 10/673,916	Applicant(s)/Patent Under Reexamination CHANG ET AL.	
	Examiner Michael Apanius	Art Unit 3736	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,704,353	01-1998	Kalb et al.	600/342
*	B	US-6,293,923	09-2001	Yachia et al.	604/96.01
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*	D	US-6,682,473	01-2004	Matsuura et al.	600/29
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	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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